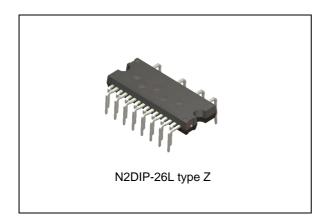
# life.augmented

#### STGIPQ8C60T-HZ

# SLLIMM<sup>™</sup> nano - 2<sup>nd</sup> series IPM, 3-phase inverter, 8 A, 600 V short-circuit rugged IGBTs

Datasheet - production data



#### **Features**

- IPM 8 A, 600 V 3-phase IGBT inverter bridge including 3 control ICs for gates driving and freewheeling diodes
- 3.3 V, 5 V and 15 V TTL/CMOS inputs comparators with hysteresis and pull down/pull up resistors
- Internal bootstrap diode
- Optimized for low electromagnetic interference
- Undervoltage lockout
- Short-circuit rugged TFS IGBTs
- · Smart shutdown function
- Interlocking function
- Op-amp for advanced current sensing
- Comparator for fault protection against overcurrent
- NTC (UL 1434 CA 2 and 4)
- Isolation rating of 1500 Vrms/min

#### **Applications**

- · 3-phase inverters for motor drives
- Home appliances such as dishwashers, refrigerator compressors, heating systems, airconditioning fans, draining and recirculation pumps

#### **Description**

This second series of SLLIMM (small low-loss intelligent molded module) nano provides a compact, high performance AC motor drive in a simple, rugged design. It is composed of six improved short-circuit rugged trench gate fieldstop IGBTs with freewheeling diodes and three half-bridge HVICs for gate driving, providing low electromagnetic interference (EMI) characteristics with optimized switching speed. The package is designed to allow a better and easy screw on heatsink, it is optimized for thermal performance and compactness in built-in motor applications, or other low power applications where assembly space is limited. This IPM includes an operational amplifier, completely uncommitted, and a comparator that can be used to design a fast and efficient protection circuit. SLLIMM™ is a trademark of STMicroelectronics.

**Table 1. Device summary** 

Order code	Marking	Package	Packaging
STGIPQ8C60T-HZ	GIPQ8C60T-HZ	N2DIP-26L	Tube

Contents STGIPQ8C60T-HZ

## **Contents**

1	Internal schematic and pin description	3
2	Absolute maximum ratings	5
	2.1 Thermal data	6
3	Electrical characteristics	7
	3.1 Inverter part	7
	3.2 Control part	9
	3.2.1 NTC thermistor	12
	3.3 Waveform definitions	14
4	Smart shutdown function	15
5	Application circuit example	17
6	Guidelines	18
7	Electrical characteristics (curves)	20
8	Package mechanical data	22
	8.1 N2DIP-26L type Z package information	22
9	Packaging mechanical data	23
10	Revision history	24

## 1 Internal schematic and pin description

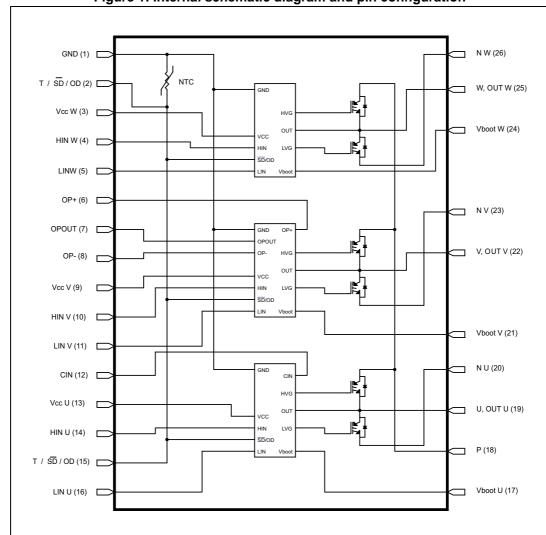


Figure 1. Internal schematic diagram and pin configuration

Table 2. Pin description

Pin	Symbol	Description
1	GND	Ground
2	T/SD/OD	NTC thermistor terminal / shutdown logic input (active low) / open-drain (comparator output)
3	V <sub>CC</sub> W	Low voltage power supply W phase
4	HIN W	High-side logic input for W phase
5	LIN W	Low-side logic input for W phase
6	OP+	Op-amp non inverting input
7	OPout	Op-amp output
8	OP-	Op-amp inverting input
9	V <sub>CC</sub> V	Low voltage power supply V phase
10	HIN V	High-side logic input for V phase
11	LIN V	Low-side logic input for V phase
12	CIN	Comparator input
13	V <sub>CC</sub> U	Low voltage power supply V phase
14	HIN U	High-side logic input for V phase
15	T/SD/OD	NTC thermistor terminal / shutdown logic input (active low) / open-drain (comparator output)
16	LIN U	Low-side logic input for U phase
17	V <sub>BOOT</sub> U	Bootstrap voltage for U phase
18	Р	Positive DC input
19	U,OUT <sub>U</sub>	U phase output
20	N <sub>U</sub>	Negative DC input for U phase
21	V <sub>BOOT</sub> V	Bootstrap voltage for V phase
22	V,OUT <sub>V</sub>	V phase output
23	N <sub>V</sub>	Negative DC input for V phase
24	V <sub>BOOT</sub> W	Bootstrap voltage for W phase
25	W,OUT <sub>W</sub>	W phase output
26	N <sub>W</sub>	Negative DC input for W phase

## 2 Absolute maximum ratings

 $(T_i = 25$ °C unless otherwise noted).

Table 3. Inverter parts

Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Collector-emitter voltage each IGBT (V <sub>IN</sub> <sup>(1)</sup> = 0 V)	600	V
I <sub>C</sub>	Continuous collector current each IGBT	8	А
I <sub>CP</sub> <sup>(2)</sup>	Peak collector current each IGBT (less than 1ms)	16	А
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> =25 °C each IGBT	19.2	W
t <sub>scw</sub>	Short-circuit withstand time $(V_{CE} = 300 \text{ V}, T_J = 125 \text{ °C}, V_{CC} = V_{boot} = 15 \text{ V}, V_{IN}^{(1)} = 0 \text{ to 5 V})$	5	μs

- 1. Applied between HINx, LINx and GND for x = U, V, W.
- 2. Pulsed width limited by max junction temperature.

**Table 4. Control parts** 

Symbol	Parameter	Min	Max	Unit
V <sub>CC</sub>	Low voltage power supply	-0.3	21	V
V <sub>BOOT</sub>	Bootstrap voltage	-0.3	620	V
V <sub>OUT</sub>	Output voltage between $\mathrm{OUT}_{\mathrm{U}},\mathrm{OUT}_{\mathrm{V}},\mathrm{OUT}_{\mathrm{W}}$ and $\mathrm{GND}$	V <sub>BOOT</sub> - 21	V <sub>BOOT</sub> + 0.3	V
V <sub>CIN</sub>	Comparator input voltage	-0.3	V <sub>CC</sub> + 0.3	V
V <sub>op+</sub>	Op-amp non-inverting input	-0.3	V <sub>CC</sub> + 0.3	V
V <sub>op-</sub>	Op-amp inverting input	-0.3	V <sub>CC</sub> + 0.3	V
V <sub>IN</sub>	Logic input voltage applied between HINx, LINx and GND	-0.3	15	V
V <sub>T/SD/OD</sub>	Open drain voltage	-0.3	15	V
$\Delta V_{OUT/dt}$	Allowed output slew rate		50	V/ns

Table 5. Total system

Symbol	mbol Parameter		Unit
V <sub>ISO</sub>	Isolation withstand voltage applied between each pin and heat sink plate (AC voltage, t = 60sec.)	9	
T <sub>J</sub>	Power chips operating junction temperature	on temperature -40 to 150	
T <sub>C</sub>	Module case operation temperature	-40 to 125	°C



## 2.1 Thermal data

Table 6. Thermal data

Symbol	Parameter	Value	Unit	
D	Thermal resistance junction-case single IGBT	6.5	0000	
K <sub>th(j-c)</sub>	Thermal resistance junction-case single diode	10	°C/W	

### 3 Electrical characteristics

 $(T_i = 25$ °C unless otherwise noted).

### 3.1 Inverter part

Table 7. Static

Symbol	Parameter	Test condition	Min	Тур	Max	Unit
I <sub>CES</sub>	Collector-cut off current (V <sub>IN</sub> <sup>(1)</sup> = 0 logic state)	V <sub>CE</sub> = 550 V, V <sub>CC</sub> = V <sub>boot</sub> = 15 V	-		250	μΑ
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	$V_{CC} = V_{Boot} = 15 \text{ V}, V_{IN}^{(1)} = 0 \text{ to } 5 \text{ V},$ $I_{C} = 8 \text{ A}$	-	2.0	2.4	٧
V <sub>F</sub>	Diode forward voltage	$V_{IN}^{(1)} = 0$ logic state, $I_C = 8$ A	1	2.4		V

<sup>1.</sup> Applied between HINx, LINx and GND for x = U, V, W

Table 8. Inductive load switching time and energy

Symbol	Parameter	Test condition	Min	Тур	Max	Unit
t <sub>on</sub> <sup>(1)</sup>	Turn-on time		-	290	-	
t <sub>con</sub> <sup>(1)</sup>	Cross-over time on	$V_{DD} = 300 \text{ V}, V_{CC} = V_{boot} = 15 \text{ V},$ $V_{IN}^{(2)} = 0 \text{ to 5 V}, I_{C} = 8 \text{ A}$ (see <i>Figure 3</i> )	-	145	-	
t <sub>off</sub> <sup>(1)</sup>	Turn-off time		-	515	-	ns
t <sub>coff</sub> <sup>(1)</sup>	Cross-over time off		-	90	-	113
t <sub>rr</sub>	Reverse recovery time		-	110	-	
E <sub>ON</sub>	Turn-on switching energy		-	200	-	
E <sub>OFF</sub>	Turn-off switching energy		-	95	-	μJ

<sup>1.</sup>  $t_{on}$  and  $t_{off}$  include the propagation delay time of the internal drive.  $t_{C(ON)}$  and  $t_{C(OFF)}$  are the switching time of IGBT itself under the internally given gate driving condition.

<sup>2.</sup> Applied between HINx, LINx and GND for x = U, V, W

Electrical characteristics STGIPQ8C60T-HZ

TIN Vboot

SD/DD HVG

HIN DUT

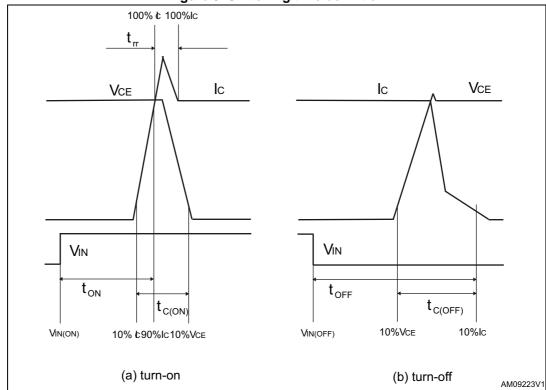
Vcc

GND

AM06019v1

Figure 2. Switching time test circuit





## 3.2 Control part

(V<sub>CC</sub>=15 V unless otherwise specified)

Table 9. Low voltage power supply

Symbol	Parameter	Test condition	Min	Тур	Max	Unit
$V_{CC\_hys}$	V <sub>CC</sub> UV hysteresis		1.2	1.5	1.8	V
V <sub>CCH_th(on)</sub>	V <sub>CCH</sub> UV turn-on threshold		11.5	12	12.5	V
V <sub>CCH_th(off)</sub>	V <sub>CCH</sub> UV turn-off threshold		10	10.5	11	V
I <sub>qccu</sub>	Under voltage quiescent supply current	$V_{CC}$ =10V; $V_{T/\overline{SD}/OD}$ =5V; $L_{IN}$ = $H_{IN}$ = $C_{IN}$ =0			150	μA
I <sub>qcc</sub>	Quiescent current	$V_{CC}$ =10 V; $V_{T/\overline{SD}/OD}$ =5V; $L_{IN}$ = $H_{IN}$ = $C_{IN}$ =0			1	mA
$V_{REF}$	Internal comparator (C <sub>IN</sub> ) reference voltage		0.51	0.54	0.56	٧

Table 10. Bootstrapped voltage

Symbol	Parameter	Test condition	Min	Тур	Max	Unit
V <sub>BS_hys</sub>	V <sub>BS</sub> UV hysteresis		1.2	1.5	1.8	V
V <sub>BS_th(on)</sub>	V <sub>BS</sub> UV turn-on threshold		11.1	11.5	12.1	V
V <sub>BS_th(off)</sub>	V <sub>BS</sub> UV turn-off threshold		9.8	10	10.6	V
I <sub>QBSU</sub>	Undervoltage V <sub>BS</sub> quiescent current	$V_{BS}$ <9V $V_{T/\overline{SD}/OD}$ =5V; $L_{IN}$ =0V; $H_{IN}$ =5V; $C_{IN}$ =0F;		70	110	μΑ
I <sub>QBS</sub>	V <sub>BS</sub> quiescent current	$V_{BS} = 15V$ $V_{T/\overline{SD}/OD} = 5V;$ $L_{IN} = 0V; H_{IN} = 5V; C_{IN} = 0F;$		150	210	μΑ
R <sub>DS(on)</sub>	Bootstrap driver on resistance	LVG ON		120		Ω

Electrical characteristics STGIPQ8C60T-HZ

Table 11. Logic inputs

Symbol	Parameter	Test condition	Min	Тур	Max	Unit
V <sub>il</sub>	Low logic level voltage				0.8	V
V <sub>ih</sub>	High logic level voltage		2.25			V
I <sub>HINh</sub>	HIN logic "1" input bias	HIN=15V	20	40	100	μΑ
I <sub>HINI</sub>	HIN logic "0" input bias current	HIN=0V			1	μΑ
I <sub>LINh</sub>	LIN logic "1" input bias current	LIN=15V	20	40	100	μΑ
I <sub>LINI</sub>	LIN logic "0" input bias current	LIN=0V			1	μΑ
I <sub>SDh</sub>	SD logic "0" input bias current	<del>SD</del> =15V	220	295	370	μΑ
I <sub>SDI</sub>	SD logic "1" input bias current	SD =0V			3	μΑ
Dt	Dead time	See Figure 8		180		ns

Table 12. Op-amp characteristics

Symbol	Parameter	Test condition	Min	Тур	Max	Unit
V <sub>io</sub>	Input offset voltage	V <sub>ic</sub> =0V, V <sub>o</sub> =7.5V			6	mV
I <sub>io</sub>	Input offset current	V <sub>ic</sub> =0V, V <sub>o</sub> =7.5V		4	40	nA
I <sub>ib</sub>	Input bias current <sup>(1)</sup>	V <sub>ic</sub> =0V, V <sub>o</sub> =7.5V		100	200	nA
V <sub>OL</sub>	Low level output voltage range	$R_L$ =10 kΩ to $V_{CC}$		75	150	mV
V <sub>OH</sub>	High level output voltage range	$R_L$ =10 kΩ to GND	14	14.7		V
	Output abort circuit ourroat	Source V <sub>id</sub> =+1V, V <sub>o</sub> =0V	16	30		mA
l <sub>o</sub>	Output short-circuit current	Sink V <sub>id</sub> =-1V, V <sub>o</sub> = V <sub>CC</sub>	50	80		mA
SR	Slew rate	V <sub>i</sub> =1-4V; C <sub>L</sub> =100pF; unity gain	2.5	3.8		V/µs
GBWP	Gain bandwidth product	V <sub>0</sub> =7.5V	8	12		MHz
A <sub>vd</sub>	Large signal voltage gain	R <sub>L</sub> =2 kΩ	70	85		dB

Table 12. Op-amp characteristics (continued)

Symbol	Parameter	Test condition	Min	Тур	Max	Unit
SVR	Supply voltage rejection ratio	vs. V <sub>cc</sub>	60	75		dB
CMRR	Common mode rejection ratio		55	70		dB

<sup>1.</sup> The direction of the input current is out of the IC.

Table 13. Sense comparator characteristics

Symbol	Parameter Test condition		Min	Тур	Max	Unit
I <sub>ib</sub>	Input bias current	V <sub>Cin</sub> =1V	-		3	μΑ
V <sub>od</sub>	Open drain low level output voltage	out I <sub>od</sub> =3mA			0.5	V
R <sub>ON_OD</sub>	Open drain low level output resistance I <sub>od</sub> =3mA		-	166		Ω
R <sub>PD_SD</sub>	SD pull down resistor <sup>(1)</sup>			125		kΩ
t <sub>d_comp</sub>	Comparator delay	$V_{T/\overline{SD}/OD}$ pulled to 5V through 100 kΩ resistor	-	90	130	ns
SR	Slew rate $C_L=180pF; R_{pu}=5 k\Omega$		-	60		V/µs
t <sub>sd</sub>	Shutdown to high/low side driver propagation delay $V_{OUT} = 0V$ , $V_{boot} = V_{CC}$ , $V_{IN} = 0$ to $3.3V$		50	125	200	ns
t <sub>isd</sub>	Comparator triggering to high/low side driver turn-off propagation delay	Measured applying a voltage step from 0V to 3.3V to pin of C <sub>IN</sub>	50	200	250	ns

<sup>1.</sup> Equivalent value as a result of the resistances of three drivers in parallel

Table 14. Truth table

Condition	Lo	gic input (V	Output		
Condition	T/SD/OD	LIN	HIN	LVG	HVG
Shutdown enable half-bridge tri-state	L	X <sup>(1)</sup>	X <sup>(1)</sup>	L	L
Interlocking half-bridge tri-state	Н	Н	Н	L	L
0 "logic state" half-bridge tri-state	Н	L	L	L	L
1 "logic state" Low side direct driving	Н	Н	L	Н	L
1 "logic state" high side direct driving	Н	L	Н	L	Н

<sup>1.</sup> X = don't care



Electrical characteristics STGIPQ8C60T-HZ

#### 3.2.1 NTC thermistor

Figure 4. Internal structure of SD and NTC<sup>(a)</sup>

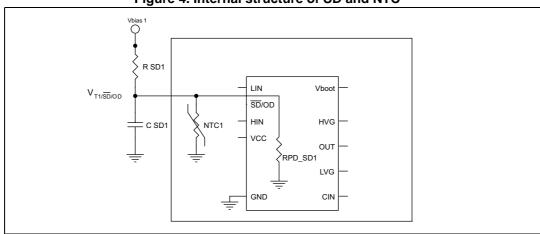
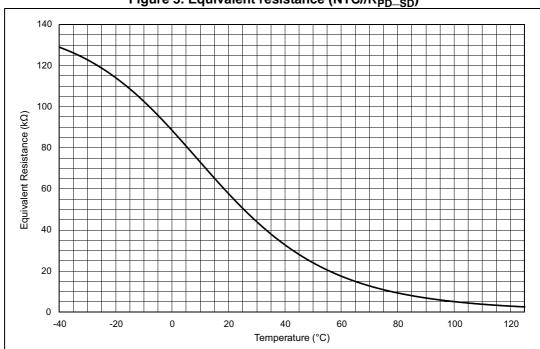


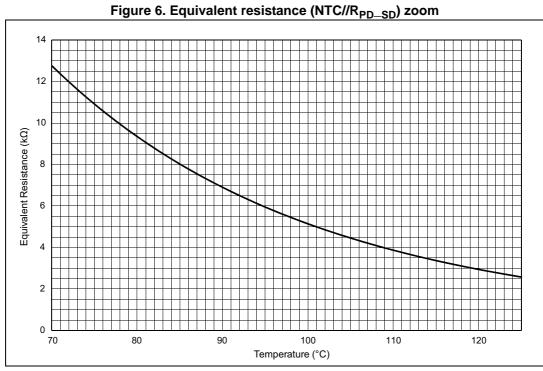
Figure 5. Equivalent resistance (NTC//R<sub>PD-SD</sub>)

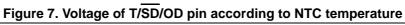


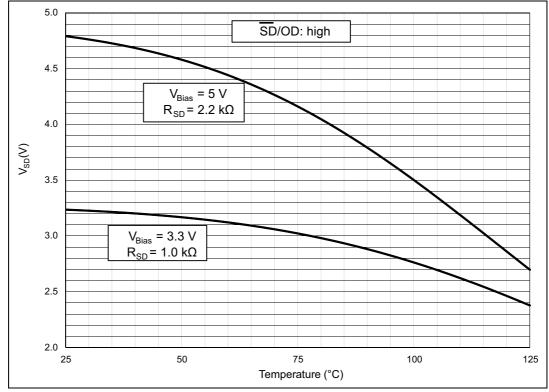
57/

12/25 DocID028908 Rev 3

a. RPD\_SD: equivalent value as result of resistances of three drivers in parallel.

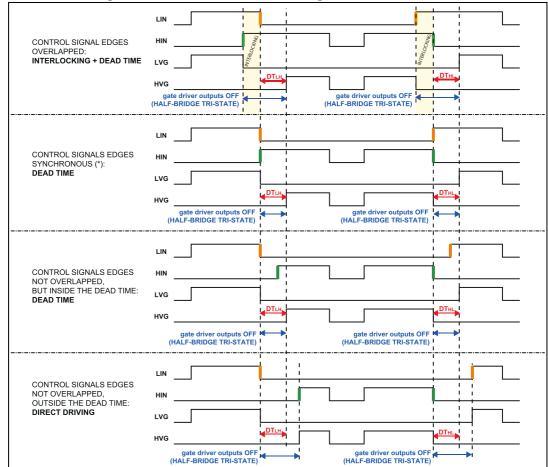






#### 3.3 Waveform definitions





#### 4 Smart shutdown function

The device integrates a comparator for fault sensing purposes. The comparator has an internal voltage reference  $V_{\mathsf{REF}}$  connected to the inverting input, while the non-inverting input on pin (CIN) can be connected to an external shunt resistor for simple overcurrent protection.

When the comparator triggers, the device is set to the Shutdown state and both its outputs are switched to the low-level setting, causing the half bridge to enter a tri-state.

In common overcurrent protection architectures, the comparator output is usually connected to the Shutdown input through an RC network that provides a mono-stable circuit which implements a protection time following a fault condition.

Our smart shutdown architecture immediately turns off the output gate driver in case of overcurrent along a preferential path for the fault signal which directly switches off the outputs. The time delay between the fault and output shutdown no longer depends on the RC values of the external network connected to the shutdown pin. At the same time, the DMOS connected to the open-drain output (pin T/SD/OD) is turned on by the internal logic, which holds it on until the shutdown voltage is lower than the logic input lower threshold (Vil).

Also, the smart shutdown function allows increasing the real disable time without increasing the constant time of the external RC network.

An NTC thermistor for temperature monitoring is internally connected in parallel to the SD pin. To avoid undesired shutdown, keep the voltage  $V_{T/\overline{SD}/OD}$  higher than the high-level logic threshold by setting the pull-up resistor  $R_{\overline{SD}}$  to 1 k $\Omega$  or 2.2 k $\Omega$  for the 3.3 V or 5 V MCU power supplies, respectively.



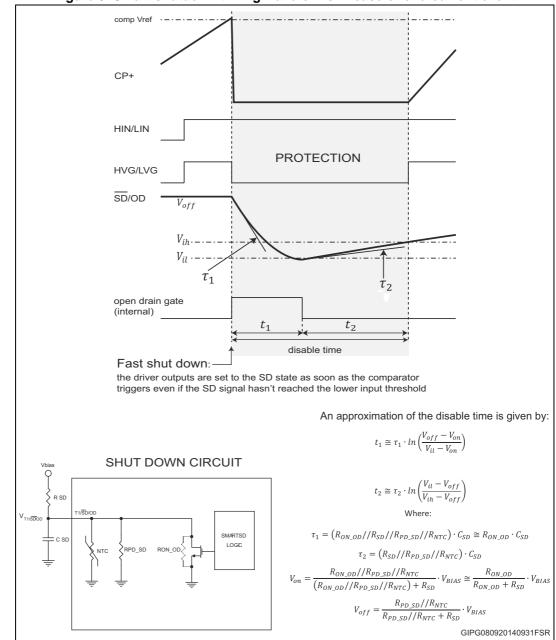


Figure 9. Smart shutdown timing waveforms in case of overcurrent event



## 5 Application circuit example

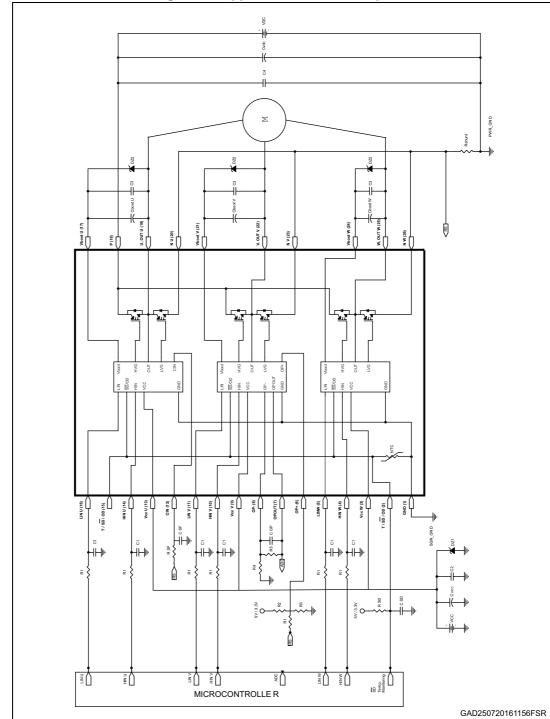


Figure 10. Application circuit example<sup>(b)</sup>

b. Application designers are free to use a different scheme according with the specifications of the device.

Guidelines STGIPQ8C60T-HZ

#### 6 Guidelines

Input signals HIN, LIN are active-high logic. A 375 kΩ (typ.) pull-down resistor is built-in
for each input. To prevent input signal oscillation, the wiring of each input should be as
short as possible and the use of RC filters (R1, C1) on each input signal is suggested.
The filters should be done with a time constant of about 100 ns and placed as close as
possible to the IPM input pins.

- The use of a bypass capacitor C<sub>VCC</sub> (aluminum or tantalum) can help to reduce the
  transient circuit demand on the power supply. Also, to reduce high frequency switching
  noise distributed on the power lines, placing a decoupling capacitor C2 (100 to 220 nF,
  with low ESR and low ESL) as close as possible to Vcc pin and in parallel whit the
  bypass capacitor is suggested.
- The use of RC filter (RSF, CSF) for preventing protection circuit malfunction is recommended. The time constant (RSF x CSF) should be set to 1 µs and the filter must be placed as close as possible to the CIN pin.
- The  $\overline{SD}$  is an input/output pin (open drain type if used as output). A built-in thermistor NTC is internally connected between the  $\overline{SD}$  pin and GND. The voltage  $V_{SD}$ -GND decreases as the temperature increases, due to the pull-up resistor  $R_{SD}$ . In order to keep the voltage always higher than the high level logic threshold, the pull-up resistor is suggested to be set at 1 k $\Omega$  or 2.2 k $\Omega$  for 3.3 V or 5 V MCU power supply, respectively. The  $C_{SD}$  capacitor of the filter on  $\overline{SD}$  should be fixed no higher than 3.3 nF in order to assure a  $\overline{SD}$  activation time  $\tau$ 1 <= 500 ns, in addition the filter should be placed as close as possible to the  $\overline{SD}$  pin.
- The decoupling capacitor C<sub>3</sub> (from 100 to 220 nF, ceramic with low ESR and low ESL), in parallel with each C<sub>boot</sub>, is useful to filter high frequency disturbance. Both C<sub>boot</sub> and C3 (if present) should be placed as close as possible to the U, V, W and V<sub>boot</sub> pins. Bootstrap negative electrodes should be connected to U, V, W terminals directly and separated from the main output wires.
- To prevent the overvoltage on Vcc pin, a Zener diode (Dz1) can be used. Similarly on the V<sub>boot</sub> pin, a Zener diode (Dz2) can be placed in parallel with each C<sub>boot</sub>.
- The use of the decoupling capacitor C4 (100 to 220 nF, with low ESR and low ESL) in parallel with the electrolytic capacitor C<sub>vdc</sub> is useful to prevent surge destruction. Both capacitors C4 and C<sub>vdc</sub> should be placed as close as possible to the IPM (C4 has priority over C<sub>vdc</sub>).
- By integrating an application-specific type HVIC inside the module, direct coupling to the MCU terminals without an opto-coupler is possible.
- Use low inductance shunt resistors for phase leg current sensing.
- In order to avoid malfunctions, the wiring between N pins, the shunt resistor and PWR\_GND should be as short as possible.
- The connection of SGN\_GND to PWR\_GND at only one point (close to the shunt resistor terminal) can help to reduce the impact of power ground fluctuation.

Note: These guidelines are useful for application design to ensure the specifications of the device. For further details, please refer to the relevant application note.

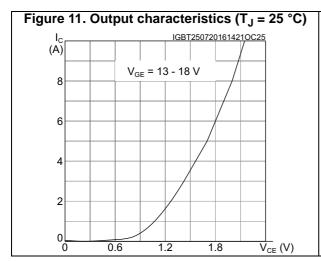
18/25 DocID028908 Rev 3

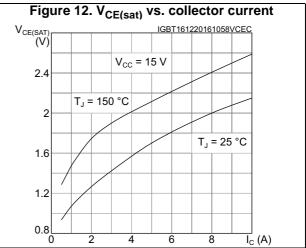
STGIPQ8C60T-HZ Guidelines

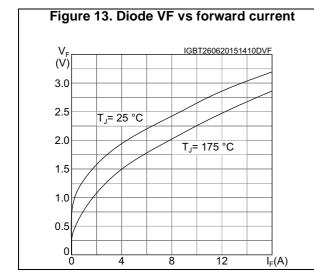
Table 15. Recommended operating conditions

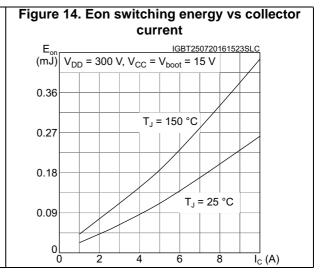
Symbol	Parameter Test condition		Min.	Тур.	Max.	Unit
V <sub>PN</sub>	Supply voltage Applied between P-N <sub>u</sub> ,N <sub>v</sub> ,N <sub>w</sub>			300	500	V
V <sub>CC</sub>	Control supply voltage	Applied between V <sub>cc</sub> -GND	13.5	15	18	V
V <sub>BS</sub>	High side bias voltage	Applied between V <sub>bootx</sub> -OUT for x=U,V,W	13		18	٧
t <sub>dead</sub>	Blanking time to prevent Armshort	For each input signal	1			μs
f <sub>PWM</sub>	PWM input signal	-40°C <t<sub>c&lt;100°C -40°C<t<sub>j&lt;125°C</t<sub></t<sub>			25	kHz
T <sub>c</sub>	Case operation temperature				100	°C

## 7 Electrical characteristics (curves)

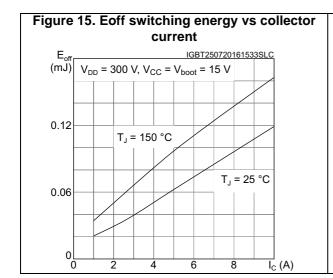


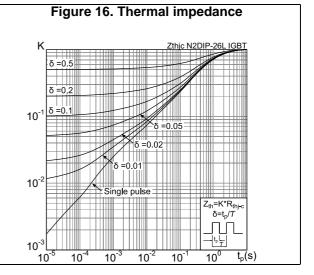






20/25 DocID028908 Rev 3





## 8 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: <a href="https://www.st.com">www.st.com</a>. ECOPACK<sup>®</sup> is an ST trademark.

#### 8.1 N2DIP-26L type Z package information

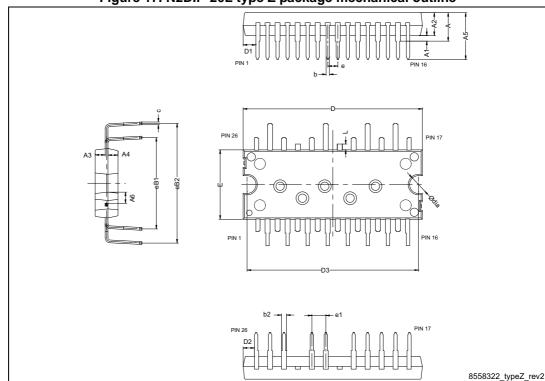


Figure 17. N2DIP-26L type Z package mechanical outline

Table 16. N2DIP-26L type Z mechanical dimensions<sup>(1)</sup>

Ref.	Di	mensio	ns	Pof	Dimensions Dimensio			Dof	ns		
Kei.	Min.	Тур.	Max.	Kei.	Min.	Тур.	Max.	Kei.	Min.	Тур.	Max.
Α	4.80	5.10	5.40	b	0.53		0.72	Е	12.35	12.45	12.55
A1	0.80	1.00	1.20	b2	0.83		1.02	е	1.70	1.80	1.90
A2	4.00	4.10	4.20	С	0.46		0.59	e1	2.40	2.50	2.60
А3	1.70	1.80	1.90	D	32.05	32.15	32.25	eB1	16.10	16.40	16.70
A4	1.70	1.80	1.90	D1	2.10			eB2	21.18	21.48	21.78
A5	8.10	8.40	8.70	D2	1.85			L	0.85	1.05	1.25
A6	1.75			D3	30.65	30.75	30.85	dia	3.10	3.20	3.30

<sup>1.</sup> All dimensions are expressed in millimeters.

57

22/25 DocID028908 Rev 3

## 9 Packaging mechanical data

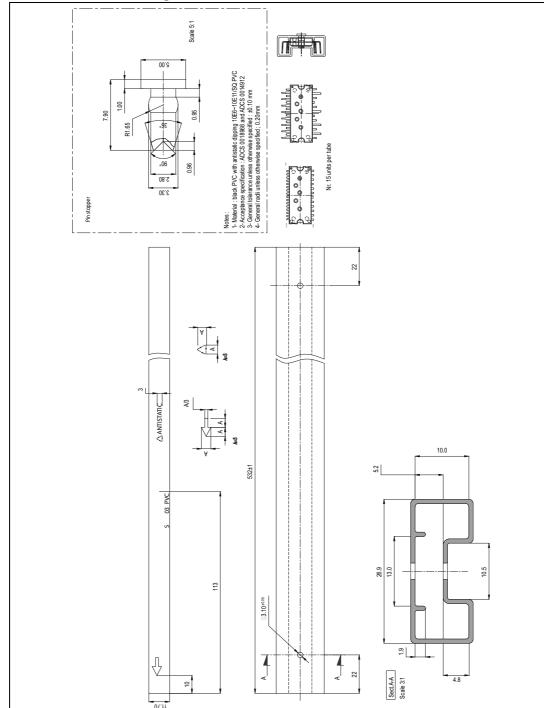


Figure 18. N2DIP-26L tube dimensions<sup>(c)</sup>

c. All dimensions are expressed in millimeters.

Revision history STGIPQ8C60T-HZ

## 10 Revision history

**Table 17. Document revision history** 

Date	Revision	Changes
22-Jan-2016	1	Initial release.
26-Jul-2016	2	Document status promoted from target to preliminary data.  Updated features in cover page, Section 3: Electrical characteristics, Section 3.2: Control part, Section 5: Application circuit example and Section 6: Guidelines.  Added Section 7: Electrical characteristics (curves).
16-Dec-2016	3	Document status promoted from preliminary to production data.  Updated <i>Figure 12: V<sub>CE(sat)</sub> vs. collector current.</i>

#### **IMPORTANT NOTICE - PLEASE READ CAREFULLY**

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2016 STMicroelectronics - All rights reserved



## **Mouser Electronics**

**Authorized Distributor** 

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

STMicroelectronics: STGIPQ8C60T-HZ